

Notice of References Cited

Application/Control No.

10/528,794

Applicant(s)/Patent Under
Reexamination
ISHIGAMI ET AL.

Examiner

Lois Zheng

Art Unit

1793

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,497,667	02-1985	Vashi, Devendra C.	148/254
*	B	US-2003/0034095	02-2003	Heimann et al.	148/245
*	C	US-2003/0162077	08-2003	Ohtani et al.	429/38
*	D	US-6,440,598	08-2002	Fukui et al.	429/34
*	E	US-5,211,663	05-1993	Kovacs et al.	623/23.6
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	O					
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